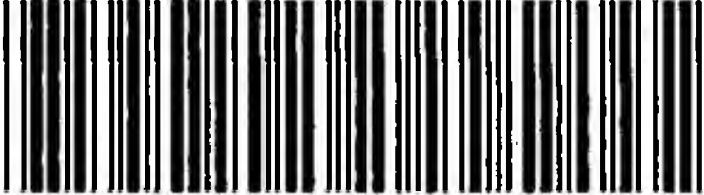


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/533,802	LEE, YEONG-CHUN	
	Examiner	Art Unit	
	Cloud K. Lee	3753	

SEARCHED			
Class	Subclass	Date	Examiner
137	360	8/8/2007	CL
137	357	8/8/2007	CL
137	358	8/8/2007	CL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR